


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595758	<b>Applicant(s)/Patent Under Reexamination</b>  MASUDA ET AL.
	<b>Examiner</b>  HUY D NGUYEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	90.2, 91, 92, 95, 420, 419	10/6/2008	HN
updated search	same as above	5/19/2009	HN

SEARCH NOTES		
Search Notes	Date	Examiner
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT, IBM_TDB). See search history.	10/6/2008	HN
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT, IBM_TDB). See search history.	5/19/2009	HN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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